Measurement-Based Real-Time Voltage Stability Monitoring for Load Areas

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NASPI Meeting in Atlanta

3/24/2016









Content

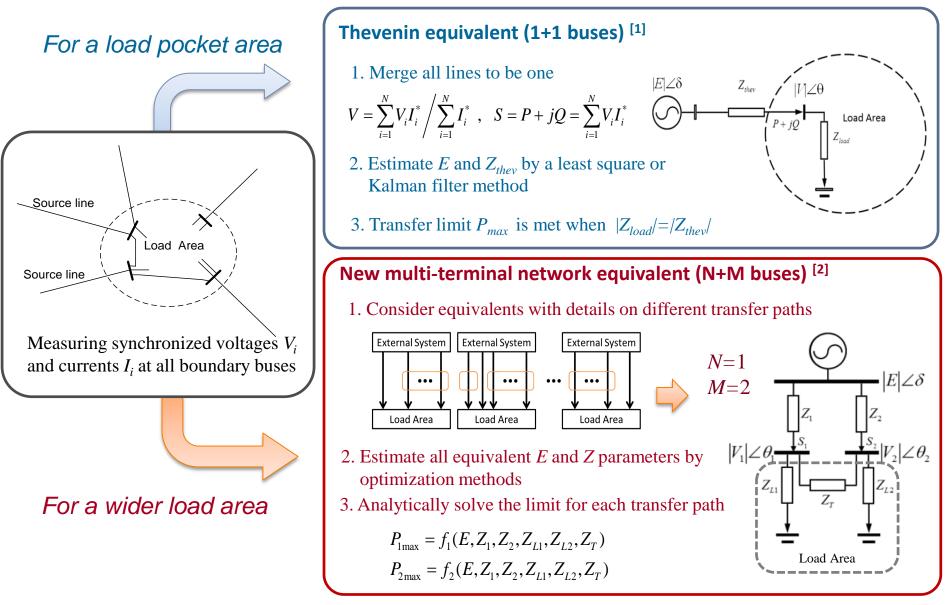
- Background on measurement-based voltage stability assessment
- •A new measurement-based VSA method and its comparison with the Thevenin method
- Demonstrations of the new method

Simulation/model based Voltage Stability Assessment

- Strengths
 - Look-ahead capabilities in stability prediction and control for "what-if" scenarios
 - Lots of commercial software tools.
- Limitations in Online Application
 - Model-dependent: the accuracy depends on how accurate the power system models is
 - **Contingency-dependent**: only applied to selected critical contingencies
 - Requiring a steady-state powerflow solution: the state estimator may fail to converge under stressed operating conditions.
 - **Computationally intensive**: especially for dynamic simulations

• An alternative approach is Measurement-based VSA

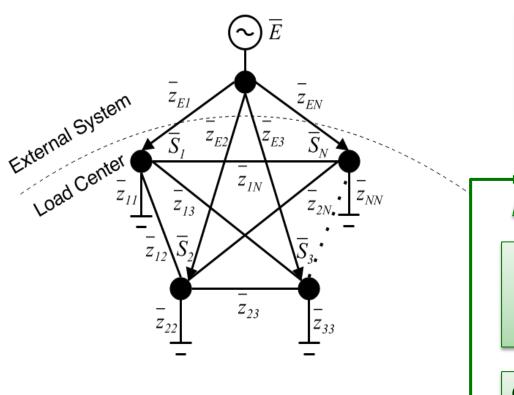
Methods for Measurement-based VSA



[1] P. Zhang, L. Min, J. Chen, Measurement-based voltage stability monitoring and control, US Patent 8,126,667, 2012

[2] F. Hu, K. Sun, A. Del Rosso, E. Farantatos, N. Bhatt, "Measurement-Based Real-Time Voltage Stability Monitoring for Load Areas," IEEE Trans. Power Systems, 2016 (DOI: 10.1109/TPWRS.2015.2477080)

New MB-VSA Method based on an N+1 buses Equivalent



Derive the transfer limit of tie line i with respect to a load change near bus j as a function of all parameters of the equivalent

$$\frac{\partial P_i(y_{11}, \cdots, y_{NN})}{\partial y_{jj}} = 0 \quad \rightarrow \quad P_{i,j}^{\text{Max}}$$

Offline place PMUs on boundary buses of the load area for voltage stability monitoring

Measure real-time voltage and current phasors

Estimate all parameters of the equivalent using phasor data over a sliding time window

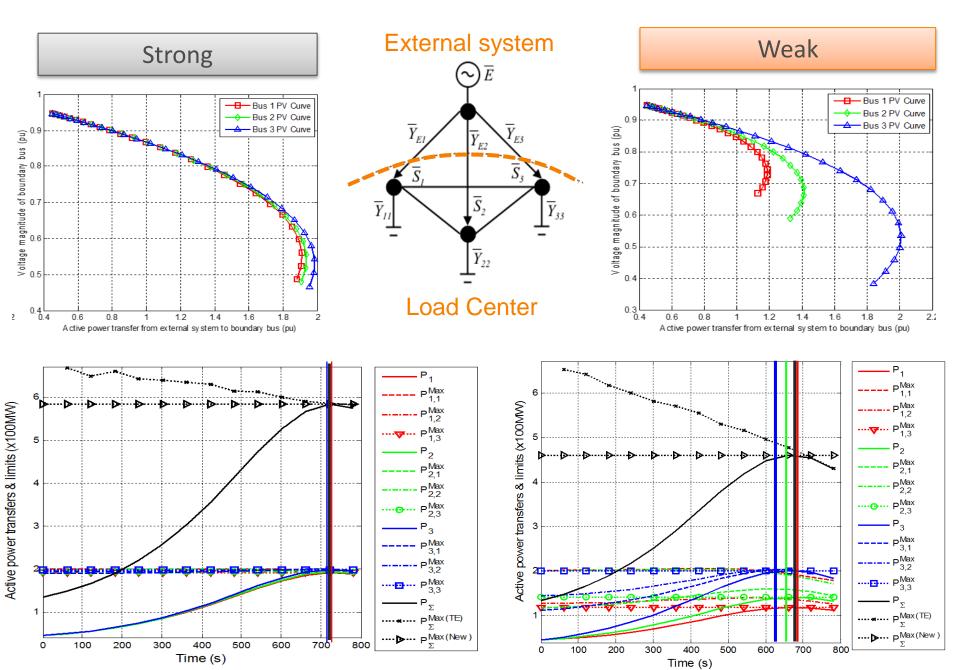
Calculate transfer limits of all tie lines by analytical expressions on P_{ij}^{max}

Real-time limit and margin information for operators

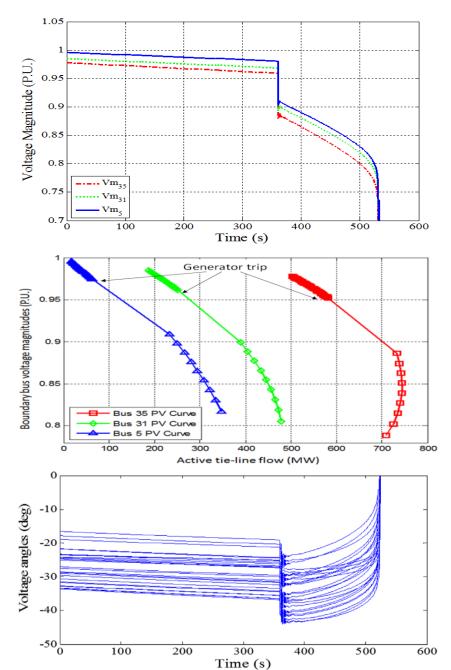
For a load area fed by multiple tie lines

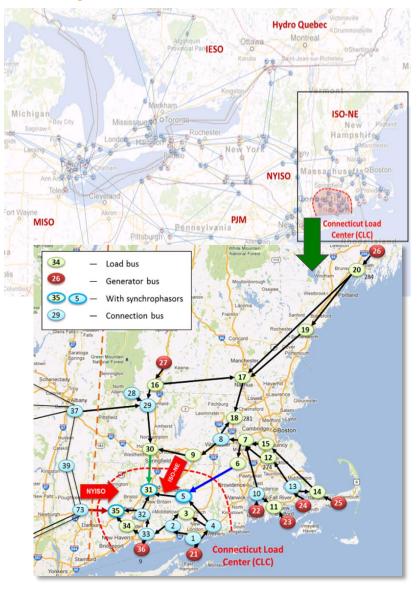
- Traditional Thevenin method
 - Only estimates the total transfer limit of all tie lines
- •New MB-VSA method
 - Estimates the transfer limit for each line and can better detect and control voltage instability if any line hits its limit earlier than the others
 - Gives the limits of each line with respect to different scenarios of load changes
 - More accurate in estimating the total transfer limit by considering the coupling among boundary buses

Influence from the coupling of boundary buses



Demonstration on the NPCC 140-bus System





Voltage collapse caused by a generator outage in the load center and load increase

Comparison of two MB-VSA methods

Time (s)

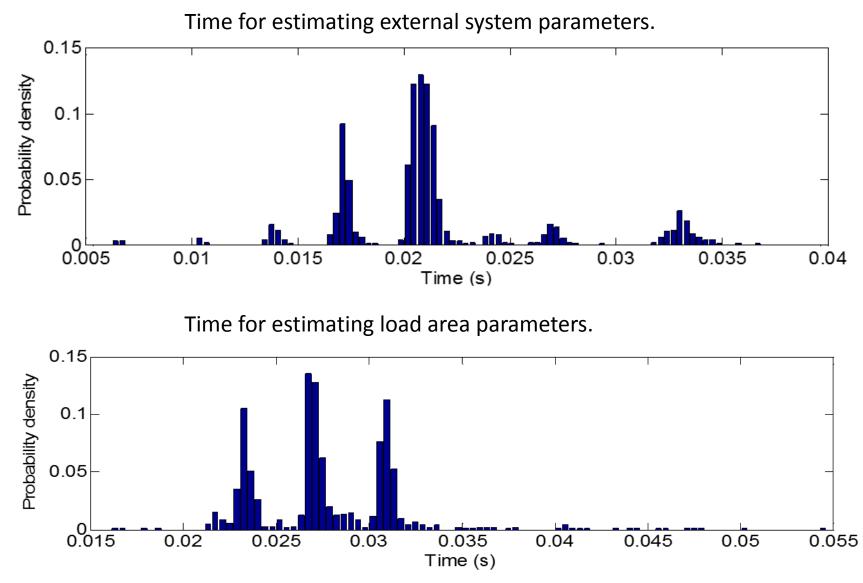
Limits (MW)

P vs.]

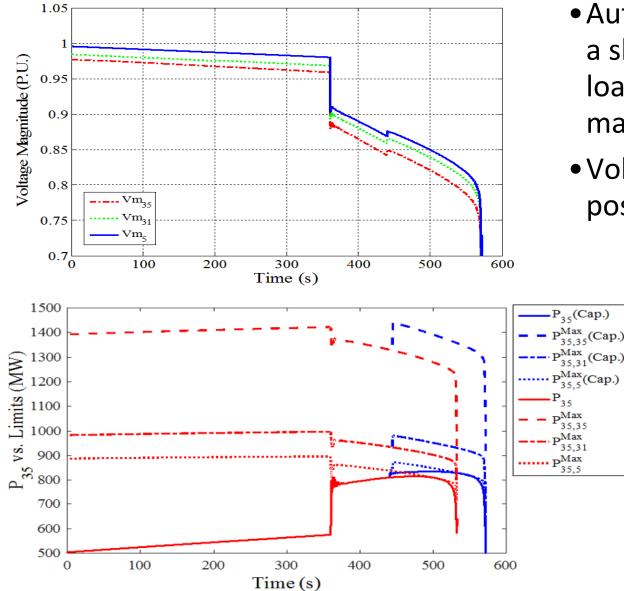
P^{Max} 35.35 Limits (MW) vs. Limits (MW) P^{Max} 35.31 p^{Max} 35.5 P₃₁ Š. P^{Max} 31.35 Ч₆ P^{Max} 31,31 ц. М P^{Max} 31,5 **D**Max 5.5 500 L 100└ 0 Time (s) Time (s) Time (s) Thevenin method Zero margin at t=473s Positive margin and limit (MW) 5000 when voltage collapse happens. Total tie-line flow

New MB-VSA

Time Performance of the New MB-VSA

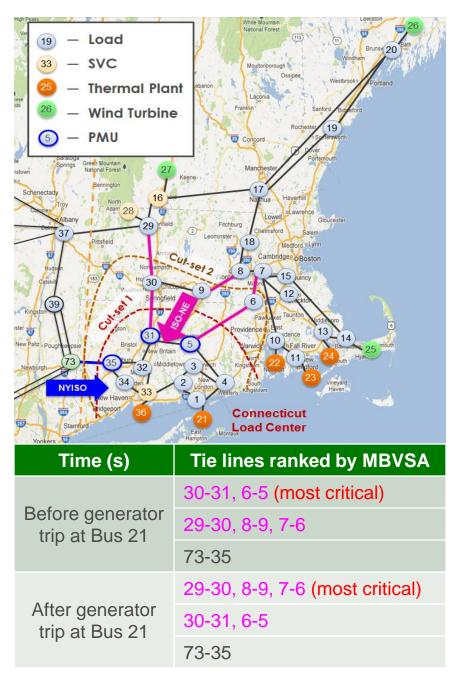


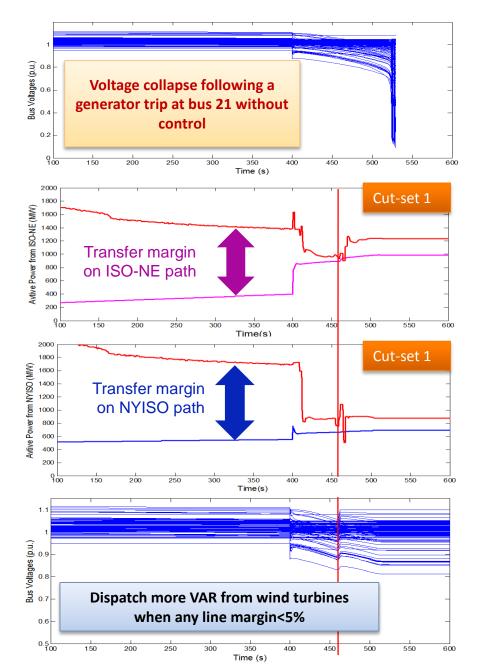
Application in Closed-loop Control



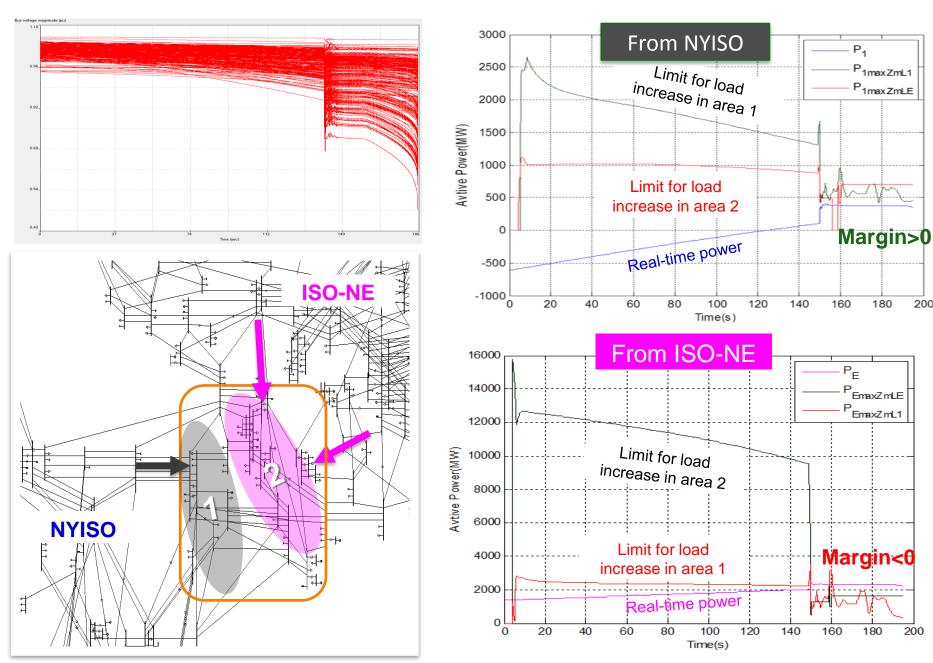
- Automatically switch in a shunt capacitor in the load area if any tie line margin drops below 5%
- Voltage collapse is postponed

Application of the New MB-VSA Method in System Operations

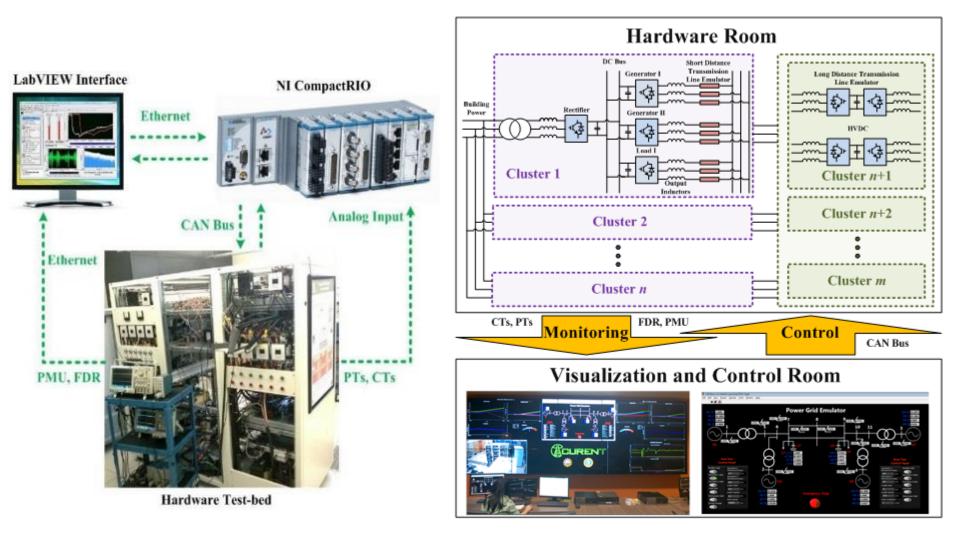




Test on a 25k-bus Eastern Interconnection model

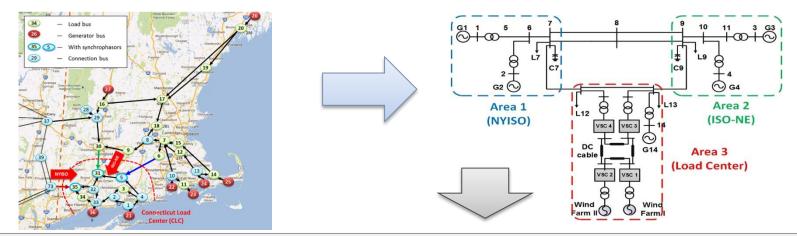


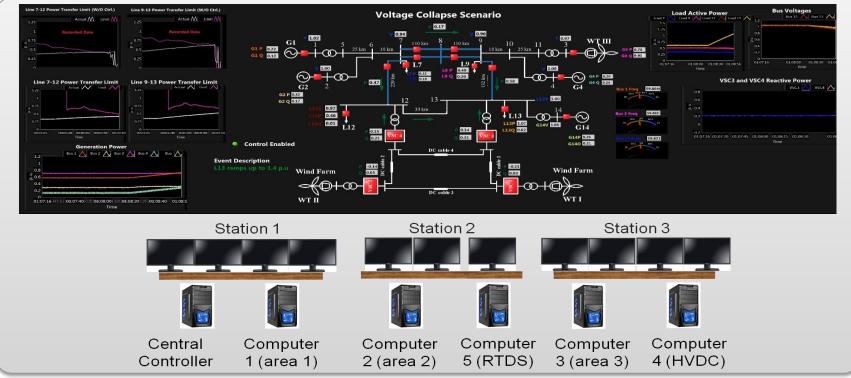
CURENT Hardware Testbed System: power converter-based reconfigurable power grid emulator ^[3]



[3] L. Yang, et al, "Development of converter based reconfigurable power grid emulator," 2014 IEEE ECCE in Pittsburgh, PA

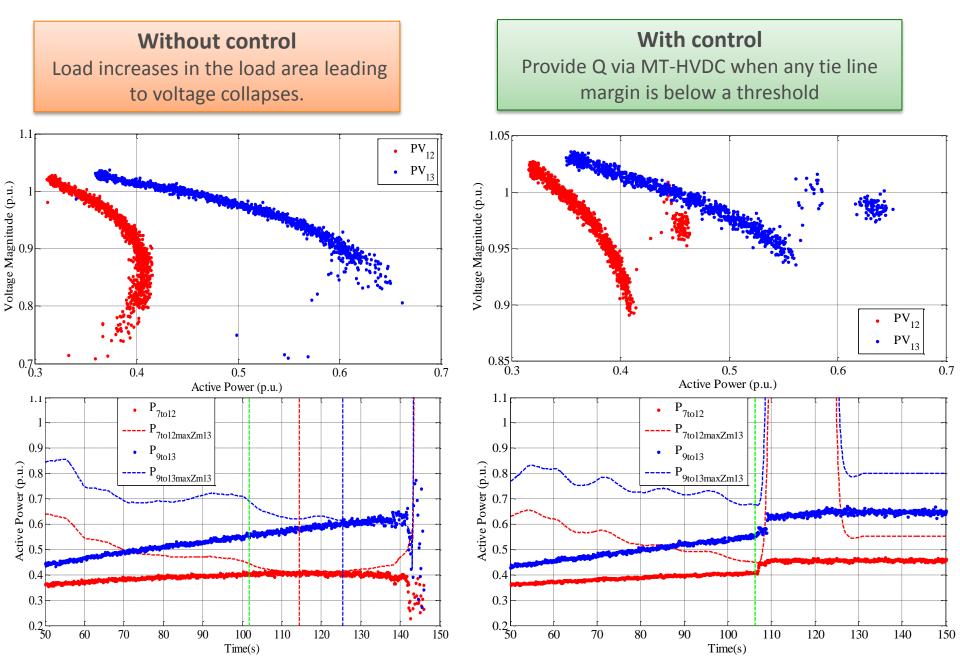
Demonstration on CURENT Hardware Test Bed System^[4]



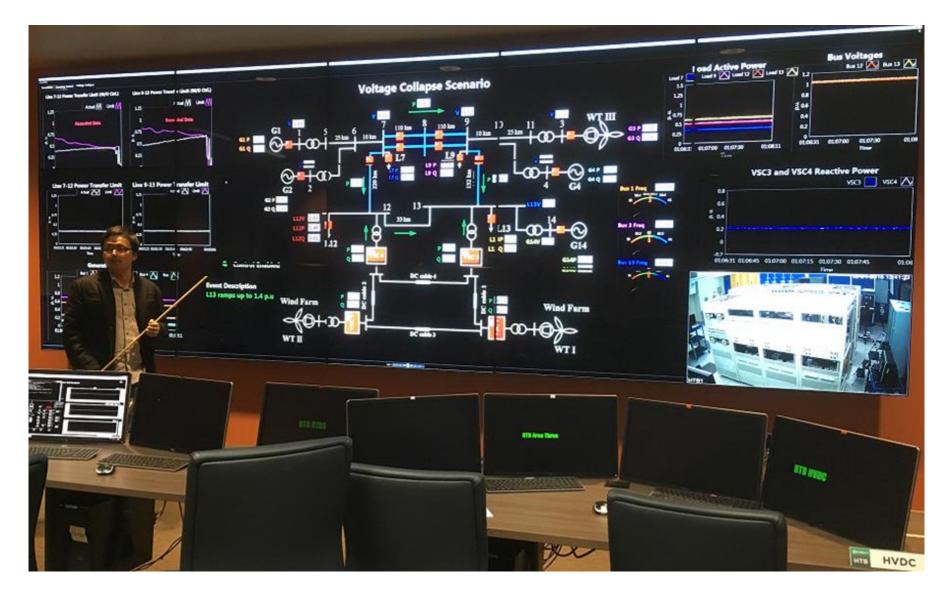


[4] F. Hu et al, "Measurement-based Voltage Stability Assessment and Control on CURENT Hardware Test Bed System," 2016 IEEE PES General Meeting in Boston, MA

Closed-loop control to prevent voltage collapse



Demonstration on CURENT Hardware Testbed System





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